

FAIRCHILD SEMICONDUCTOR

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FAIRCHILD

A Schlumberger Company

FDH600/FDLL600
FDH666/FDLL666

T-03-09

Ultra Fast Diodes

- C... 2.5 pF (MAX) FDH600, 3.5 pF (MAX) FDH666
- V_F ... 1.0 V (MAX) @ 100 mA (FDH666)
- ... 1.0 V (MAX) @ 200 mA (FDH600)
- t_{rr} ... 4.0 ns (MAX) @ $I_f = I_r = 10$ mA

PACKAGES

FDH600	DO-35
FDH666	DO-35
FDLL600	LL-34
FDLL666	LL-34

ABSOLUTE MAXIMUM RATINGS (Note 1)

Temperatures

Storage Temperature Range	-65°C to +200°C
Maximum Junction Operating Temperature	+175°C
Lead Temperature	+260°C

If you need this device in the SOT package, an electrical equivalent is available. See FDSO1200 family.

Power Dissipation (Note 2)

Maximum Total Dissipation at 25°C Ambient	500 mW
Linear Derating Factor (from 25°C)	3.33 mW/°C

Maximum Voltage and Currents

	FDH 600	FDH 666
WIV Working Inverse Voltage	50 V	25 V
I_O Average Rectified Current	200 mA	200 mA
I_F Continuous Forward Current	500 mA	500 mA
i_f Recurrent Peak Forward Current	600 mA	600 mA
i_f (surge) Peak Forward Surge Current		
	Pulse Width = 1.0 s	1.0 A
	Pulse Width = 1.0 μ s	4.0 A

ELECTRICAL CHARACTERISTICS (25°C Ambient Temperature unless otherwise noted)

SYMBOL	CHARACTERISTIC	FDH600		FDH666		UNITS	TEST CONDITIONS
		MIN	MAX	MIN	MAX		
V_F	Forward Voltage		1.0			V	$I_F = 200$ mA
			0.92		1.0	V	$I_F = 100$ mA
			0.86		0.86	V	$I_F = 50$ mA
			0.79		0.79	V	$I_F = 10$ mA
			0.65		0.65	V	$I_F = 1.0$ mA
I_R	Reverse Current		0.1			μ A	$V_R = 50$ V
					0.1	μ A	$V_R = 25$ V
			100		100	μ A	$V_R = 50$ V, $T_A = 150^\circ$ C
					100	μ A	$V_R = 25$ V, $T_A = 150^\circ$ C
BV	Breakdown Voltage	75		40		V	$I_R = 5.0$ μ A
t_{rr}	Reverse Recovery Time (Note 3)		4.0		4.0	ns	$I_f = I_r = 10$ mA, $R_L = 100$ Ω
			6.0		6.0	ns	$I_f = I_r = 200$ mA, $R_L = 100$ Ω
C	Capacitance		2.5		3.5	pF	$V_R = 0$, $f = 1.0$ MHz

NOTES:

1. The maximum ratings are limiting values above which life or satisfactory performance may be impaired.
2. These are steady state limits. The factory should be consulted on applications involving pulsed or low duty-cycle operation.
3. Recovery to 0.1 I_R .
4. For product family characteristic curves, refer to Chapter 4, D4.

